


Issue Classification 		Application/Control No. 10045397	Applicant(s)/Patent under Reexamination HASEGAWA, YUTAKA	
		Examiner Tran, Philip B	Art Unit 2155	

ORIGINAL		INTERNATIONAL CLASSIFICATION			
CLASS	SUBCLASS		CLAIMED		NON-CLAIMED
709	206	G 0 6 F		15 / 16	
CROSS REFERENCE(S)					
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
709	203	217			
(Assistant Examiner) <i>Laminia Johnson</i> (Legal Instruments Examiner)		(Date) 11-15-06 (Date)		Philip Tran Philip B. Tran (Primary Examiner)	
				Total Claims Allowed: 13	
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